

Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-207001	Application No. 10/756,756
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Hajime Kimura et al.		
		Filing Date January 14, 2004	Group Art Unit 2673 2628	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
ls	AA	2002-0057244	05/16/2002	Koyama et al.	—	—	11/09/2001
ss	AB	2002-0135309	09/26/2002	Okuda	—	—	01/22/2002
ss	AC	2003-0048669	03/13/2003	Abe	—	—	08/29/2002
ss	AD	2003-0128199	07/10/2003	Kimura	—	—	10/29/2002
ss	AE	2003-0128200	07/10/2003	Yumoto	—	—	11/07/2001
ss	AF	2003-0156012	08/21/2003	Omidi et al.	—	—	12/21/2001
ss	AG	2003-0156102	08/21/2003	Kimura	—	—	10/29/2002
ss	AH	2003-0169250	09/11/2003	Kimura	—	—	10/29/2002
ss	AI	2004-0085029	05/06/2004	Kimura	—	—	10/30/2002
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ss	AK	2004-0207578	10/21/2004	Koyama	—	—	12/10/2003
ss	AL	2004-0222985	11/11/2004	Kimura	—	—	12/04/2003
ss	AM	2004-0257356	12/23/2004	Koyama	—	—	07/08/2004
ss	AN	2006-0028413	02/09/2006	Kimura	—	—	09/09/2005
ss	AO	5,138,310	08/11/1992	Hirane et al.	—	—	10/30/1990
ss	AP	5,266,936	11/30/1993	Saitoh	—	—	05/04/1992
ss	AQ	5,805,123	09/08/1998	Satoh et al.	—	—	03/18/1996
ss	AR	5,953,003	09/14/1999	Kwon et al.	—	—	10/06/1997
ls	AS	6,020,865	02/01/2000	Okuda et al.	—	—	10/02/1996
ss	AT	6,057,183	05/02/2000	Koyama et al.	—	—	11/19/1997
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ss	AV	6,229,506	05/08/2001	Dawson et al.	—	—	04/22/1998
ss	AW	6,268,842	07/31/2001	Yamazaki et al.	—	—	04/09/1999
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ss	BA	6,373,454	04/16/2002	Knapp et al.	—	—	06/09/1999

Examiner Signature	Jeff Pizat	Date Considered	8-6-2007
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BD	BD	6,545,652	04/08/2003	Tsuji	—	—	07/06/2000
BE	BE	6,586,888	07/01/2003	Kitahara et al.	—	—	03/22/2002
BF	BF	6,714,091	03/30/2004	Norskov et al.	—	—	12/19/2000
BG	BG	6,777,885	08/17/2004	Koyama	—	—	10/08/2002
BH	BH	6,809,320	10/26/2004	Iida et al.	—	—	09/17/2002
BI	BI	6,876,345	04/05/2005	Akimoto et al.	—	—	02/15/2002
BJ	BJ	6,876,350	04/05/2005	Koyama	—	—	08/08/2002
BK	BK	6,909,442	06/21/2005	Hiyama et al.	—	—	08/21/2002
BL	BL	6,914,390	07/05/2005	Koyama	—	—	11/19/2003
BM	BM	6,924,601	08/02/2005	Date	—	—	12/04/2003
BN	BN	6,927,753	08/09/2005	Koyama et al.	—	—	11/02/2001
BO	BO	6,952,194	10/04/2005	Yamazaki et al.	—	—	03/28/2000
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BQ	BQ	6,954,035	10/11/2005	Chien et al.	—	—	01/14/2004
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BS							

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Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Sub-class	Translation
							Yes No
BT	BT	EP1 063 630	27 DEC 2000	EUROPE	—	—	In English
BU	BU	EP1 102 234	23 MAY 2001	EUROPE	—	—	In English
BV	BV	JP06-118913	28 APR 1994	JAPAN	—	—	Full
BW	BW	JP07-036410	07 FEB 1995	JAPAN	—	—	Abstract
BX	BX	JP08-095522	12 APR 1996	JAPAN	—	—	Abstract
BY	BY	JP08-101669	16 APR 1996	JAPAN	—	—	Abstract

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							Yes No
BB	BZ	JP08-106075	23 APR 1996	JAPAN	—	—	Abstract
BB	CA	JP10-312173	24 NOV 1998	JAPAN	—	—	Full
BB	CB	JP11-183870	09 JULY 1999	JAPAN	—	—	Abstract
BB	CC	JP11-231834	27 AUG 1999	JAPAN	—	—	Abstract
BB	CD	JP11-282419	15 OCT 1999	JAPAN	—	—	Abstract
BB	CE	JP2000-122607	28 APR 2000	JAPAN	—	—	Abstract
BB	CF	JP2000-194428	14 JULY 2000	JAPAN	—	—	Abstract
BB	CG	JP2000-267164	29 SEP 2000	JAPAN	—	—	Abstract
BB	CH	JP2001-005426	12 JAN 2001	JAPAN	—	—	Abstract
BB	CI	JP2001-034221	09 FEB 2001	JAPAN	—	—	Abstract
BB	CJ	JP2001-042822	16 FEB 2001	JAPAN	—	—	Abstract
BB	CK	JP2001-042847	16 FEB 2001	JAPAN	—	—	Abstract
BB	CL	JP2001-056667	27 FEB 2001	JAPAN	—	—	Full
BB	CM	JP2001-147659	29 MAY 2001	JAPAN	—	—	Abstract
BB	CN	JP2001-290469	19 OCT 2001	JAPAN	—	—	Abstract
BB	CO	JP2002-215095	31 JULY 2002	JAPAN	—	—	Abstract
BB	CP	JP2002-278497	27 SEP 2002	JAPAN	—	—	Abstract
BB	CQ	JP2002-514320	14 MAY 2002	JAPAN	—	—	Abstract
BB	CR	JP2002-517806	18 JUNE 2002	JAPAN	—	—	Abstract
BB	CS	JP2003-066903	05 MAR 2003	JAPAN	—	—	Abstract
BB	CT	JP3287391	04 JUN 2002	JAPAN	—	—	Abstract
BB	CU	JP62-122488	04 AUG 1987	JAPAN	—	—	Full
BB	CV	WO98-048403	29 OCT 1998	WIPO / PCT	—	—	In English
BB	CW	WO99-065011	16 DEC 1999	WIPO / PCT	—	—	In English
BB	CX	WO02-039420	16 MAY 2002	WIPO / PCT	—	—	Abstract
BB	CY	WO03-034381	24 APR 2003	WIPO / PCT	—	—	In English
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Other Documents (include Author, Title, Date, and Place of Publication)			
Examiner Initial	Desig. ID	Document	
<i>JP</i>	DA	Yumoto et al., "Pixel-Driving Methods for Large-Sized Poly-Si AM-OLED Displays," <i>Asia Display / IDW '01</i> , Jan. 1, 2001, pp. 1395-1398.	
<i>JP</i>	DB	Hattori et al., "Analog-Circuit Simulation of the Current-Programmed Active-Matrix Pixel Electrode Circuits Based on Poly-Si TFT for Organic Light-Emitting Displays," <i>Digest of Technical Papers, AM-LCD '01</i> , July 11, 2001, pp. 223-226.	
<i>JP</i>	DC	Abe et al., "A Poly-Si TFT 6-bit Current Data Driver for Active Matrix Organic Light Emitting Diode Displays," <i>EuroDisplay '02</i> , Jan. 1, 2002, pp. 279-282.	
<i>JP</i>	DD	R. Hattori, "Data-Line Driver Circuits for Current-Programmed Active-Matrix OLED Based on Poly-Si TFT's," <i>Digest of Technical Papers AM-LCD '02</i> , Jan. 1, 2002, pp. 17-20	

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DD	AB	2002/0149608	10/17/2002	BU et al.	—	—	04/15/2002
DD	AC	2002/0180369	12/05/2002	KOYAMA	—	—	02/20/2002
DD	AD	2004/0085270	05/06/2004	KIMURA	—	—	10/30/2002
DD	AE	2004/0207578	10/21/2004	KOYAMA	—	—	12/10/2003
DD	AF	2004/0232952	11/25/2004	KIMURA et al.	—	—	01/14/2004
DD	AG	2004/0239599	12/02/2004	KOYAMA	—	—	07/02/2004
DD	AH	2005/0002260	01/06/2005	KOYAMA	—	—	07/30/2004
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DD	AJ	3,982,172	09/21/1976	VAN DE PLASSCHE	—	—	04/16/1975
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DD	AL	6,747,624	06/08/2004	UDO et al.	—	—	02/09/2000
DD	AM	6,777,710	08/17/2004	KOYAMA	—	—	02/20/2002
DD	AN	6,801,061	10/05/2004	COWLES	—	—	08/29/2002
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						

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Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes No
DD	AU	0359315	03/21/1990	Europe	—	—	In English
DD	AV	1202242	05/02/2002	Europe	—	—	In English
DD	AW	1486942	12/15/2004	Europe	—	—	In English
DD	AX	1577869	09/21/2005	Europe	—	—	In English

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DD	AY	2001-056664	02/27/2001	Japan	—	—	Abstract
DD	AZ	2002-221936	08/09/2002	Japan	—	—	Abstract
DD	AAA	2002-251166	09/06/2002	Japan	—	—	Abstract

Other Documents (include Author, Title, Date, and Place of Publication)		
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DD	ABB	GROENEVELD D. et al., "A Self-Calibration Technique for Monolithic High-Resolution D/A Converters", IEEE Journal of Solid-State Circuits, 1989, Vol. 24, No. 6, pp. 1517-1522
DD	ACC	TAN S. et al., "32.4: Designing of Circuit Building-Blocks for OLED-on-Silicon Microdisplays", SID DIGEST 02: SID International Symposium Digest of Technical Papers, 2002, pp. 980-983
DD	ADD	Supplementary European Search Report (Application No. EP 03780930.8, PCT/JP0316354 dated February 20, 2007), 5 pages.
	AEE	

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